



N- and P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY							
	V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)			
N-Channel	30	0.055 at $V_{GS} = 4.5 \text{ V}$	4 ^{a,g}	4.2 nC			
		0.090 at V _{GS} = 2.5 V	4 ^{a,g}	4.2110			
P-Channel	- 30	$0.150 \text{ at V}_{GS} = -4.5 \text{ V}$	- 3.6 ^a	2.85 nC			
		0.256 at V _{GS} = - 2.5 V	- 2.7 ^a	2.00 110			

FEATURES

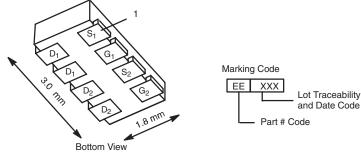
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFETs
- Compliant to RoHS Directive 2002/95/EC

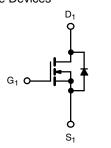


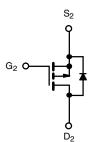


APPLICATIONS

- Buck-Boost
 - DSC
 - Portable Devices







Ordering Information: Si5511DC-T1-E3 (Lead (Pb)-free)

1206-8 ChipFET®

Si5511DC-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted							
Parameter		Symbol	N-Channel	P-Channel	Unit		
Drain-Source Voltage	V _{DS}	30	- 30	V			
Gate-Source Voltage	V_{GS}	±	V				
	T _C = 25 °C		4 ^{a, g}	- 3.6 ^a			
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C	I _D	4 ^{a, g}	- 2.8 ^a			
Continuous Diam Curiem (1) = 130 °C)	T _A = 25 °C	טי	4 ^{a, g}	- 2.3 ^{b, c}			
	T _A = 70 °C		3.9 ^a	- 1.8 ^{b, c}	Α		
Pulsed Drain Current	I _{DM}	15	- 10	1			
Source Drain Current Diode Current	T _C = 25 °C	I _S	2.6	- 2.6			
Source Diam Current Blode Current	T _A = 25 °C	·9	1.7 ^{b, c}	- 1.7 ^{b, c}			
	T _C = 25 °C		3.1	2.6			
Maximum Power Dissipation	T _C = 70 °C	P_D	2.0	1.7	w		
Maximum Fower Dissipation	T _A = 25 °C	٠ ٥	2.1 ^{b, c}	1.3 ^{b, c}	VV		
	T _A = 70 °C		1.33 ^{b, c}	0.84 ^{b, c}			
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 150		°C			
Soldering Recommendations (Peak Temperature) ^d		260					

THERMAL RESISTANCE RATINGS								
			N-Channel P-Channel					
Parameter		Symbol	Тур.	Max.	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	50	60	77	95	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	30	40	33	40	5/ **	

Notes:

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. See Reliability Manual for profile. The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequade bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 110 °C/W for N-Channel and 130 °C/W for P-Channel.
- g. Package limited.

Si5511DC Vishay Siliconix



Parameter	Symbol	Test Conditions		Min.	Typ. ^a	Max.	Unit
Static							<u> </u>
Drain Course Breakdown Voltage	V	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	N-Ch	30			V
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	P-Ch	- 30			V
V Tompovotuvo Coefficient	AV /T	I _D = 250 μA	N-Ch		24.2		mV/°C
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA	P-Ch		- 23.1		
V Tamana watuwa Ca afficiant	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	N-Ch		3.6		
V _{GS(th)} Temperature Coefficient		I _D = - 250 μA	P-Ch		2.3		
O . T	.,	$V_{DS} = V_{GS}, I_D = 250 \mu A$	N-Ch	0.7		2	V
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	P-Ch	- 0.7		- 2	
Cata Pady Lankaga	lana	V = 0 V V = + 12 V	N-Ch			100	nA
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	P-Ch			- 100	
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	N-Ch			1	μΑ
Zoro Coto Voltago Droin Current	lana	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$	P-Ch			- 1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	N-Ch			10	
		$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	P-Ch			- 10	
On-State Drain Current ^b	I _{D(on)}	$V_{DS} \le 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	N-Ch	15			А
		$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	P-Ch	- 10			
	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 4.8 \text{ A}$	N-Ch		0.045	0.055	
		$V_{GS} = -4.5 \text{ V}, I_D = -2.3 \text{ A}$	P-Ch		0.125	0.150	Ω
Drain-Source On-State Resistance ^b		$V_{GS} = 2.5 \text{ V}, I_D = 3.8 \text{ A}$	N-Ch		0.075	0.090	
		$V_{GS} = -2.5 \text{ V}, I_D = 1.8 \text{ A}$	P-Ch		0.213	0.256	
h		$V_{DS} = 15 \text{ V}, I_D = 4.8 \text{ A}$	N-Ch		10.8		
Forward Transconductance ^b	9 _{fs}	V _{DS} = - 15 V, I _D = - 2.3 A	P-Ch		6.56		S
Dynamic ^a							
•			N-Ch		435		
Input Capacitance	C _{iss}	N-Channel	P-Ch		260		pF
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	N-Ch		65		
Cutput Cupuoliulioc	Joss	P-Channel	P-Ch		55		
Reverse Transfer Capacitance	C _{rss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	N-Ch		30		
· · · · · · · · · · · · · · · · · · ·		V 45.V.V 5.V.L 4.0.A	P-Ch		42		
	Q_{g}	$V_{DS} = 15 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 4.8 \text{ A}$	N-Ch		4.7	7.1	
Total Gate Charge		$V_{DS} = -15 \text{ V}, V_{GS} = -5 \text{ V}, I_{D} = -3.2 \text{ A}$	P-Ch		4.1	6.2	nC
		N-Channel	N-Ch		4.2	6.3	
	Q _{gs}	V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 4.8 A P-Channel V _{DS} = - 15 V, V _{GS} = - 4.5 V, I _D = - 3.2 A	P-Ch N-Ch		3.8 1.1	4.6	
Gate-Source Charge			P-Ch		0.6		
	Q _{gd}		N-Ch		0.9		
Gate-Drain Charge			P-Ch		1.85		
Cota Basistanas	П	N	N-Ch		2.7		
Gate Resistance	R_g	f = 1 MHz	P-Ch		7.7		Ω





SPECIFICATIONS $T_J = 25$ °C, unless otherwise noted											
Parameter	arameter Symbol Test Conditions			Min.	Typ. ^a	Max.	Unit				
Dynamic ^a											
Turn-On Delay Time	t _{d(on)}	N. G.	N-Ch		9	12					
Turn On Belay Time	'a(on)	N-Channel $V_{DD} = 15 \text{ V, R}_{L} = 3.95 \Omega$	P-Ch		15	23					
Rise Time	t _r	$I_{D} \cong 3.8 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_{q} = 1 \Omega$	N-Ch		45	68					
	1	1D = 0.0 /1, VGEN = 4.0 V, Fig = 132	P-Ch		78	117	ns				
Turn-Off Delay Time	t _{d(off)}	P-Channel	N-Ch		48	72	- - -				
	u(on)	$V_{DD} = -15 \text{ V}, R_{L} = 18.1 \Omega$	P-Ch		33	50					
Fall Time	t _f	$I_D \cong$ - 1.86 A, V_{GEN} = - 4.5 V, R_g = 1 Ω	N-Ch		28	42					
		-	P-Ch		65	98					
Drain-Source Body Diode Characteristic	s										
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	N-Ch			2.6]				
	-3	Ŭ	P-Ch			- 2.6	Α				
Pulse Diode Forward Current ^a	I _{SM}		N-Ch			15	, ,				
r disc blode i olward current			P-Ch			- 10					
Body Diode Voltage	V _{SD}	$I_S = 2.4 \text{ A}, V_{GS} = 0 \text{ V}$	N-Ch		0.8	1.2	V				
Body Blode Voltage		$I_S = -1.5 \text{ A}, V_{GS} = 0 \text{ V}$	P-Ch		- 0.8	- 1.2					
Body Diode Reverse Recovery Time	t _{rr}		N-Ch		11.6	18	ns				
Body Diode neverse necovery Time			P-Ch		19.8	30					
Body Diode Reverse Recovery Charge	Q _{rr}	N-Channel $I_F = 2.4 \text{ A}$, $dI/dt = 100 \text{ A/}\mu\text{s}$, $T_A = 25 ^{\circ}\text{C}$	N-Ch		6.1	9.2	nC				
		i _F = 2.4 Λ, αί/αι = 100 Α/μs, 1 _J = 25 °C	P-Ch		17.5	27	2				
Reverse Recovery Fall Time	ta	P-Channel	N-Ch		8.4						
Tieverse riecovery i all fillie		$I_F = -1.5 \text{ A}, \text{ dI/dt} = -100 \text{ A/µs}, T_J = 25 °C$	P-Ch		17.2		ns				
Reverse Recovery Rise Time	t _b		N-Ch		3.2		110				
Tieverse Hecovery Hise Hille	ъ		P-Ch		2.6						

Notes

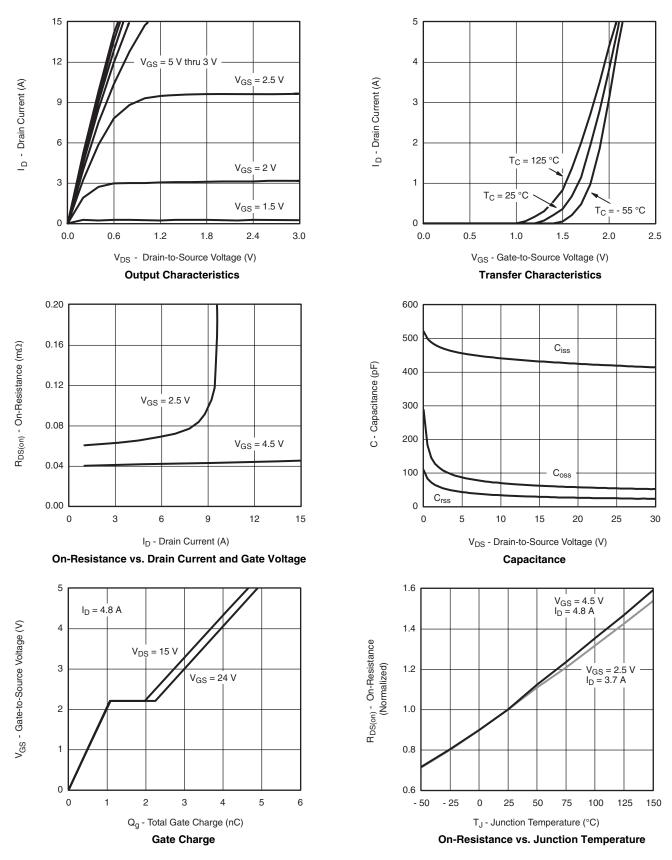
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.



N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

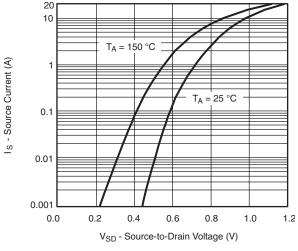


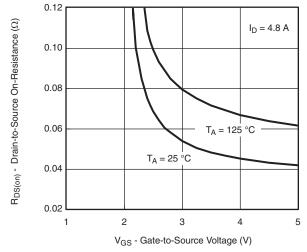






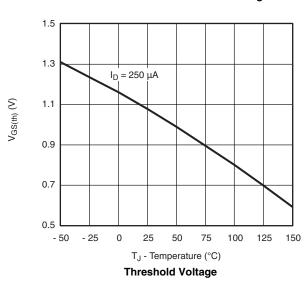
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

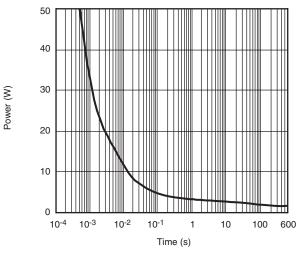




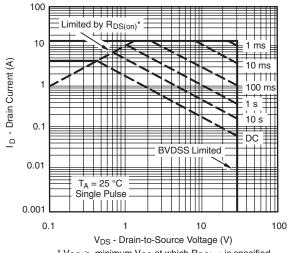
Source-Drain Diode Forward Voltage







Single Pulse Power

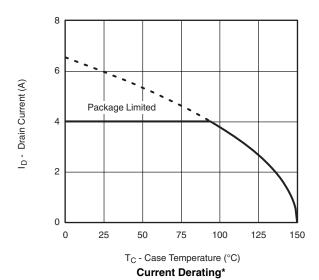


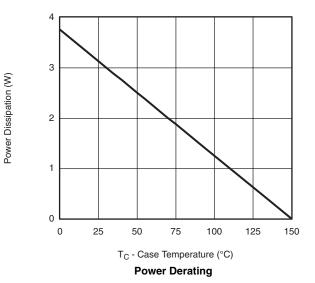
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

VISHAY

N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

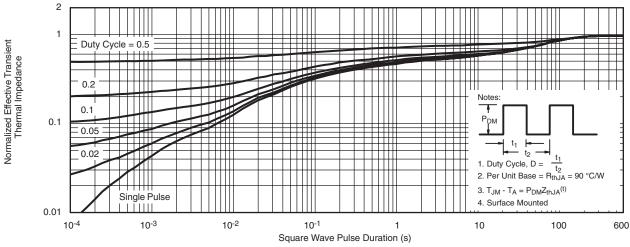




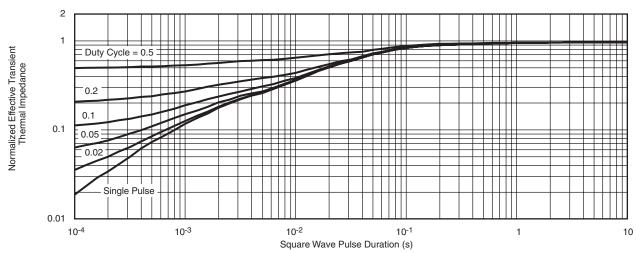
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



N-CHANNEL TYPICAL CHARACTERISTICS 25 $^{\circ}$ C, unless otherwise noted



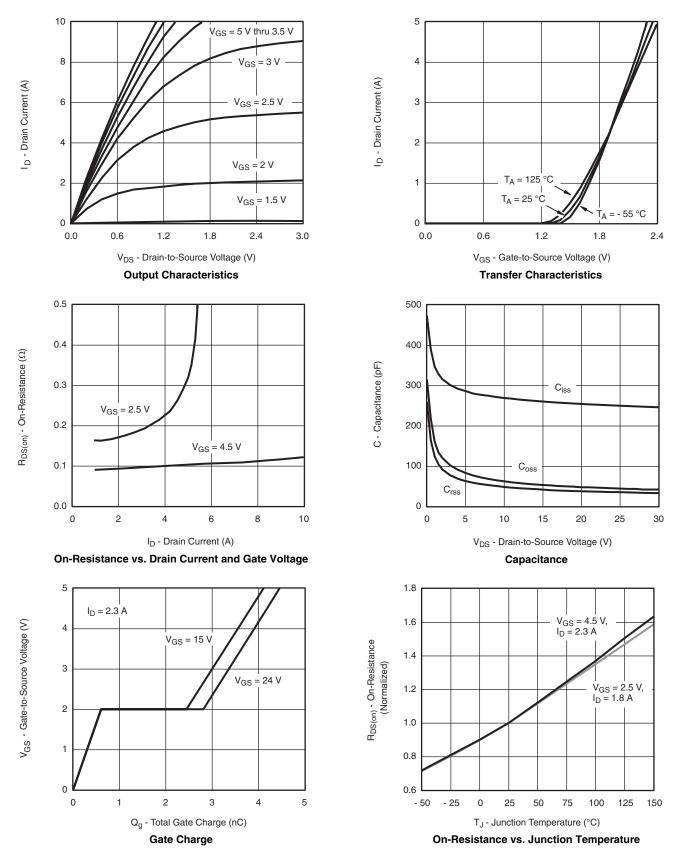
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

VISHAY

P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

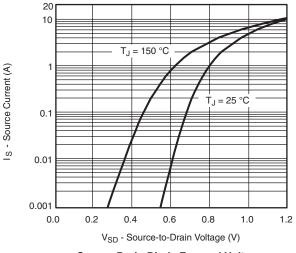


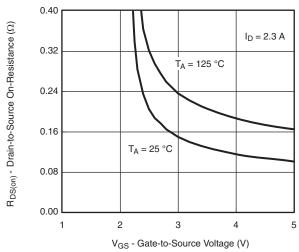






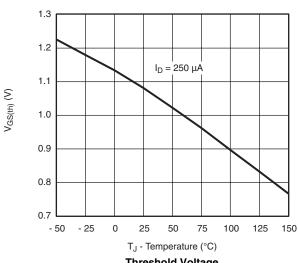
P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

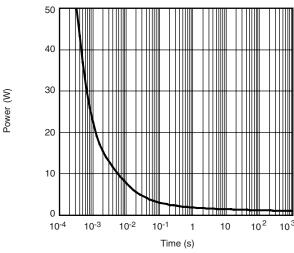




Source-Drain Diode Forward Voltage

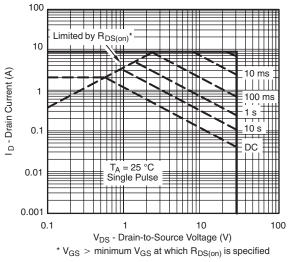






Threshold Voltage

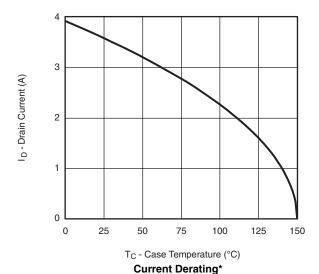
Single Pulse Power

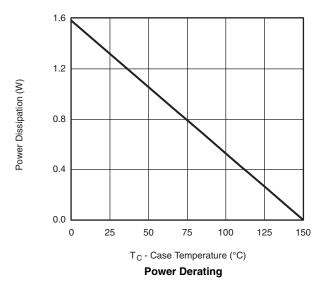


Safe Operating Area, Junction-to-Case

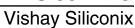


P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



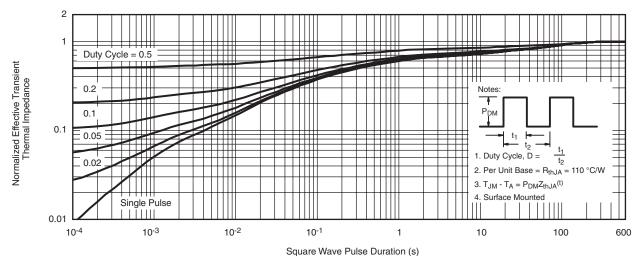


^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

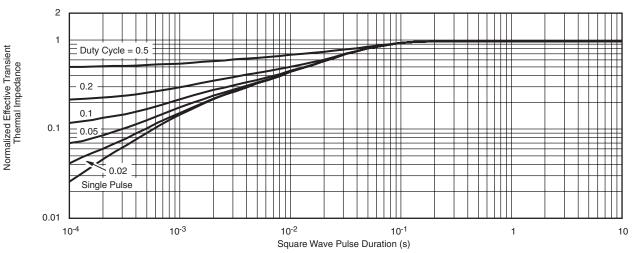




P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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